

Data sheet acquired from Harris Semiconductor SCHS103C – Revised July 2003

CD40160B, CD40161B, CD40162B, CD40163B Types

CMOS Synchronous Programmable 4-Bit Counters

High-Voltage Types (20-Volt Rating)

 $\label{eq:cde} \textbf{CD40160B} - \textbf{Decade with Asynchronous}$

Clear

CD40161B — Binary with Asynchronous

Clear

CD40162B — Decade with Synchronous Clear

CD40163B — Binary with Synchronous Clear

■ CD40160B, CD40161B, CD40162B, and CD40163B are 4-bit synchronous programmable counters. The CLEAR function of the CD40162B and CD40163B is synchronous and a low level at the CLEAR input sets all four outputs low on the next positive CLOCK edge. The CLEAR function of the CD40160B and CD40161B is asynchronous and a low level at the CLEAR input sets all four outputs low regardless of the state of the CLOCK, LOAD, or ENABLE inputs. A low level at the LOAD input disables the counter and causes the output to agree with the setup data after the next CLOCK pulse regardless of the conditions of the ENABLE inputs.

The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a carry output (COUT). Counting is enabled when both PE and TE inputs are high. The TE input is fed forward to enable COUT. This enabled output produces a positive output pulse with a

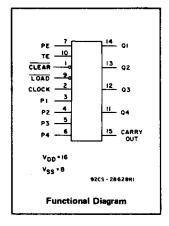
Features:

- Internal look-ahead for fast counting
- Carry output for cascading
- Synchronously programmable
- Clear asynchronous input (CD40160B, CD40161B)
- Clear synchronous input (CD40162B, CD40163B)
- Synchronous load control input
- Low-power TTL compatibility
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range;
 100 nA at 18 V and 25°C
- Noise margin (over full package-temperaature range): 1 V at V_{DD} = 5 V
 2 V at V_{DD} = 10 V
 2.5 V at V_{DD} = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

duration approximately equal to the positive portion of the Q1 output. This positive overflow carry pulse can be used to enable successive cascaded stages. Logic transitions at the PE or TE inputs may occur when the clock is either high or low.

The CD40160B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix). The CD40161B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

The CD40160B through CD40163B types are functionally equivalent to and pin-compatible with the TTL counter series 74LS160 through 74LS163 respectively.



Applications:

- Programmable binary and decade counting
- Counter control/timers
- Frequency dividing

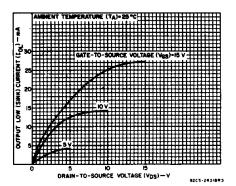


Fig. 1 — Typical output low (sink) current characteristics.

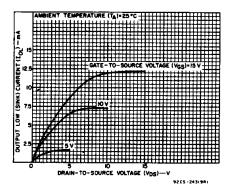


Fig. 2— Minimum output low (sink) current characteristics.

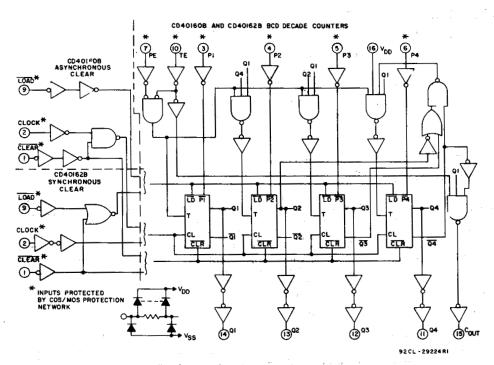


Fig. 3— Logic diagrams for CD40160B and CD40162B BCD decade counters.

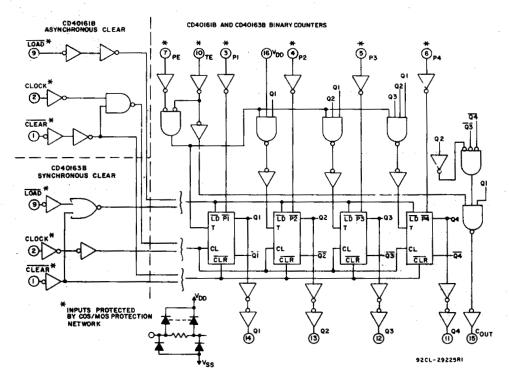


Fig. 4— Logic diagrams for CD40161B and CD40163B binary counters.

RECOMMENDED OPERATING CONDITIONS at $T_A = 25^{\circ}$ C, Except as Noted For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V _{DD}	LIM	ITS	UNITS	
	(V)	MIN.	MAX.	1	
Supply Voltage Range (Full T _A = Full Package - Temperature Range)	_	3	18	v	
Setup Time: t _{SU} Data to Clock	5 10 15	240 90 60	· -	ns	
Load to Clock	. 5 10 15	240 90 60	* *	ns	
PE or TE to Clock	5 10 15	340 140 100	1 1 1	П\$	
Clear to Clock (CD40162B, CD40163B)	5 10 15	340 140 100	-	ns	
All Hold Times, t _H	5 10 15	0 0 0	-	ns	
Clear Removal Time, t _{rem} (CD40160B, CD40161B)	5 10 15	200 100 70	<u>-</u>	ns	
Clear Pulse Width, t _{WL} (CD40160B, CD40161B)	5 10 15	170 70 50	-	ns	
Clock Input Frequency, fCL	5 10 15	_ _ _	2 5.5 8	MHz	
Clock Pulse Width, t _W	5 10 15	170 70 50	_ _ _	ns	
Clock Rise or Fall Time, t _F CL or t _f CL	5 10 15	-	200 70 15	μs	

TRUTH TABLE

CLOCK	CLR	LOAD	PE	TE	OPERATION
	1	0	х	х	PRESET
	1	1	0	х	NC
	1	1.,	×	0	NC
	1	1	1	1	COUNT
х	0	×	х	х	RESET (CD40160B, CD40161B)
	.0	×	х	х	RESET (CD40162B, CD40163B)
	1	х	х	х	NC (CD40162B, CD40163B)

1 - HIGH LEVEL

0 = LOW LEVEL

X = DON'T CARE

NC = NO CHANGE

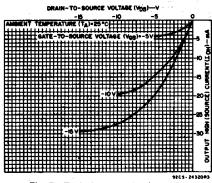


Fig. 5— Typical output high (source) current characteristics.

DRAIN-TO-SOURCE VOLTAGE (VDS)--V

Fig. 6— Minimum output high (source) current characteristics.

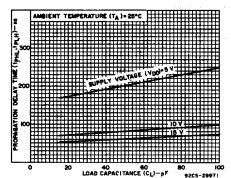


Fig. 7— Typical propagation delay time as a function of load capacitance (CLOCK to Q).

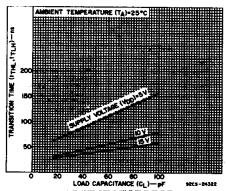


Fig. 8— Typical transition time as a function of load capacitance.

STATIC ELEC	RIGAL	UNAK!	-U1E	nialic	•				- · · ·		Т
CHARAC- TERISTIC	CON	DITIO	LIMITS AT INDICATED TEMPERATURES (°C)								NIT
	v _o	VIN	V _{DD}				A _g		+25		s
	(V)	(V)	(V)	55	-40	+85	+125	Min.	Тур.	Max.]
Quiescent		0,5	5	- 5	5	150	150	-	0.04	5	
Device	- , ;	0,10	10	10	10	300	300	+	0.04	10	اسم
Current, IDD Max.		0,15	15	20	20	600	600		0.04	20]
יטטיייטטי.	_ :	0,20	20	100	100	3000	3000	-	0.08	100	1.
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	. 1	- :	
(Sink) Current	0.5	0,10	10	1.6	1.5	1,1	0.9	: 1.3	2.6	<u> </u>	1
OL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_	
Output High (Source) Current,	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	- 1	_	mΑ
	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	_	1
	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	1.
I _{OH} Min.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8		1
Output Voltage:	+	0,5	5		0.	05	-	0	0.05		
Low-Level,	-	0,10	10		0.	.05		_	. 0	0.05	1
V _{OL} Max.	-	0,15	15		. 0.	.05		_	0	0.05	ľv
Output .	_	0,5	5		. 4.	95		4.95	5	_	`
Voltage: High-Level,	_	0,10	10		9.	.95		9.95	10	_	1
VOH Min.	_	0,15	15	in."	, 14.	.95		14.95	15		
Input Low	0.5,4.5	-	5			1.5			-:	1.5	
Voltage	1,9	1	10			3		-	-	3	1
V _I L Max.	1.5,13.5	1	15			4		Ţ		4	v
Input High	0.5,4.5	-	5			3.5		3.5	· _:	_	
Voltage,	1,9	1	10	1		7		7		-	
V _{IH} Min.	1.5,13.5	_	15			11		11		-	1
Input Current IN Max.	-	0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μА

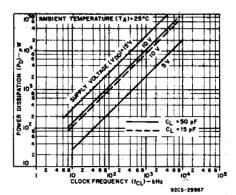


Fig. 9— Typical power dissipation as a function of CLOCK frequency.

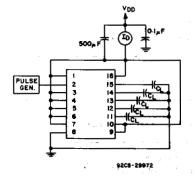


Fig. 10— Dynamic power dissipation test circuit.

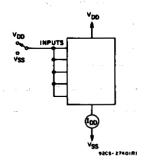


Fig. 11 — Quiescent-device-current test circuit

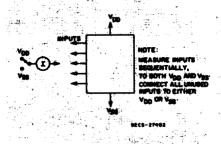


Fig. 12- Input-current test circuit.

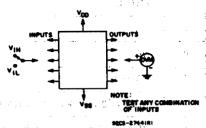
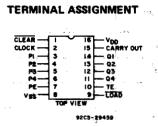


Fig. 13- Input-voltage test circuit.



DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C; Input t_r , t_f = 20 ns, C_L = 50 pF, R_L = 200 $k\Omega$

CHARACTERISTIC	TEST CONDITIONS		LIMITS ALL TYPES*				
	V _{DD} (V)	Min.	Тур.	Max.	UNITS		
CLOCK OPERATION				<u> </u>			
Propagation Delay Time, tpHL,tpLH Clock to Q	5 10 15	-	200 80	400 160	ns		
Clock to COUT	5 10 15		225 95 70	120 450 190 140	ns		
TE to COUT	5 10 15	-	125 55 40	250 110 80	ns		
Minimum Setup Time, tŞU Data to Clock	5 10 15	- - -	120 45 30	240 90 60	ns		
Load to Clock	5 10 15	<u>-</u> -	120 45 30	240 90 60	ns		
PE to TE to Clock	5 10 15		170 70 50	340 140 100	ns		
Minimum Hold Time, t _H	5 10 15			0 0 0	ns		
Transition Time, t _{THL} ,t _{TLH}	. err - 5 . Nogerier 10 15	- - -	100 50 40	200 100 80	ns		
Minimum Clock Pulse Width, t _W	5 10 15	_ _ _ 	85 35 25	170 70 50	n\$		
Maximum Clock Frequency, f _{CL}	5 10 15	2 5.5 8	3 8.5 12		MHz		
Maximum Clock Rise or Fall Time, [†] t _r CL, t _{fCL}	5 10 15	200 70 15	1 1 1	- -	μs		
CLEAR OPERATION							
Propagation Delay Time, tPHL (CD40160B, CD40161B) Clear to Q	5 10 15	-	250 110 80	500 220 160	n\$		
Minimum Setup Time, tsu (CD40162B, CD40163B) Clear to Clock	5 .10 .15		170 70 50	340 140 100	ns		
Minimum Hold Time, t _H (CD40162B, CD40163B) Clear to Clock	5 10 15	-		000	ns		
Minimum Clear Removal Time, t _{rem} (CD40160B, CD40161B)	5 10 15		100 50 35	200 100 70	ns		
Minimum Clear Pulse Width, twL (CD40160B, CD40161B)	5 10 15	-	85 35 25	170 70 50	ns		

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^{*} Except as noted.
† If more than one unit is cascaded in the parallel clocked application, t.CL should be made less than or equal to the sum of the fixed propagation delay at 50 pF and the transition time of the carry output driving stage for the estimated capacitive load.

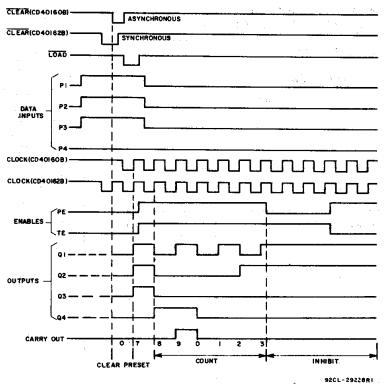


Fig. 14— Timing diagram for CD40160B, CD40162B.

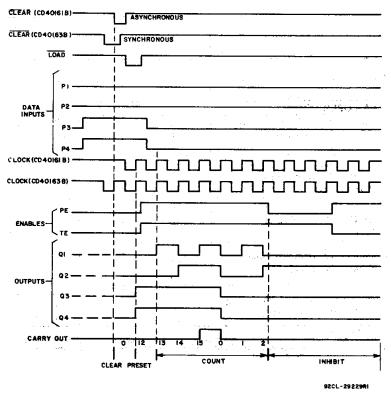


Fig. 15- Timing diagram for CD40161B, CD40163B.

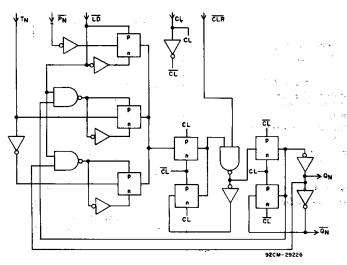
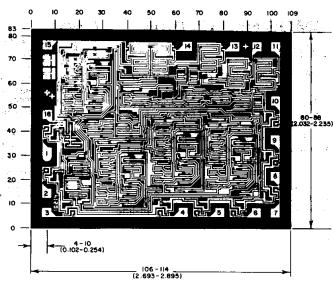


Fig. 16— Detail of flip-flops of CD40160B and CD40161B (asynchronous clear).



Dimensions and pad layout for CD40160BH. Dimensions and pad layout for CD40161BH, CD40162BH, and CD40163BH are identical.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).

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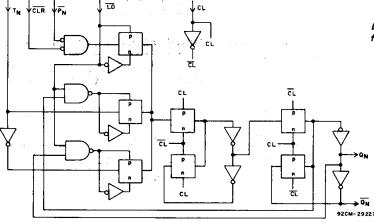


Fig. 17— Detail of flip-flops for CD40162B and CD40163B (synchronous clear).

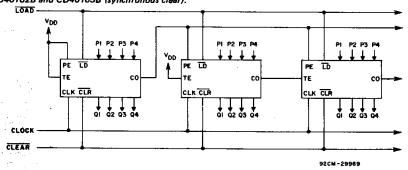


Fig. 18 - Cascaded counter packages in the parallel-clocked mode.

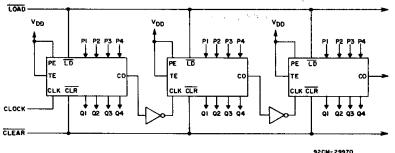


Fig. 19 — Cascaded counter packages in the ripple-clocked mode.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(0)	(4)	(5)		(0)
CD40160BF3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD40160BF3A
CD40160BF3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD40160BF3A
CD40161BE	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD40161BE
CD40161BE.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD40161BE
CD40161BF3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD40161BF3A
CD40161BF3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD40161BF3A
CD40161BNSR	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD40161B
CD40161BNSR.A	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD40161B
CD40161BPWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM0161B
CD40161BPWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM0161B

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD40161B, CD40161B-MIL:

Military : CD40161B-MIL

NOTE: Qualified Version Definitions:

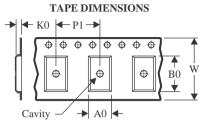
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

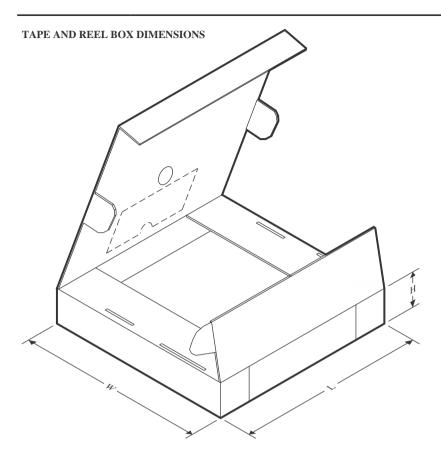
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD40161BNSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
CD40161BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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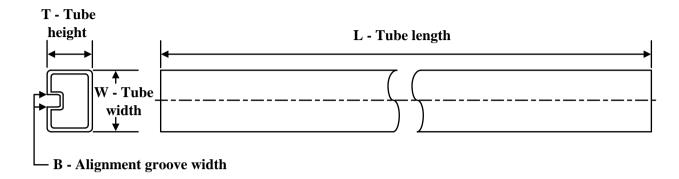
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD40161BNSR	SOP	NS	16	2000	353.0	353.0	32.0
CD40161BPWR	TSSOP	PW	16	2000	353.0	353.0	32.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD40161BE	N	PDIP	16	25	506	13.97	11230	4.32
CD40161BE	N	PDIP	16	25	506	13.97	11230	4.32
CD40161BE.A	N	PDIP	16	25	506	13.97	11230	4.32
CD40161BE.A	N	PDIP	16	25	506	13.97	11230	4.32

MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



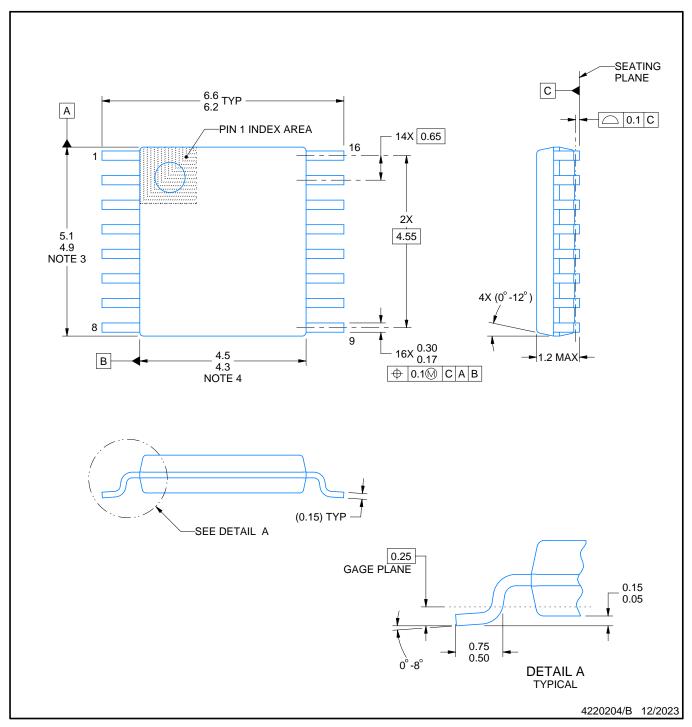
14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.



SMALL OUTLINE PACKAGE



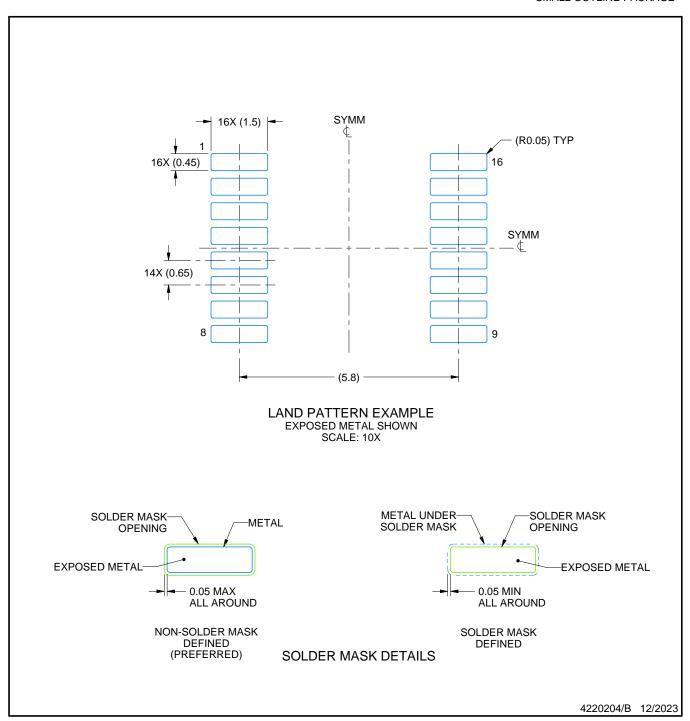
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



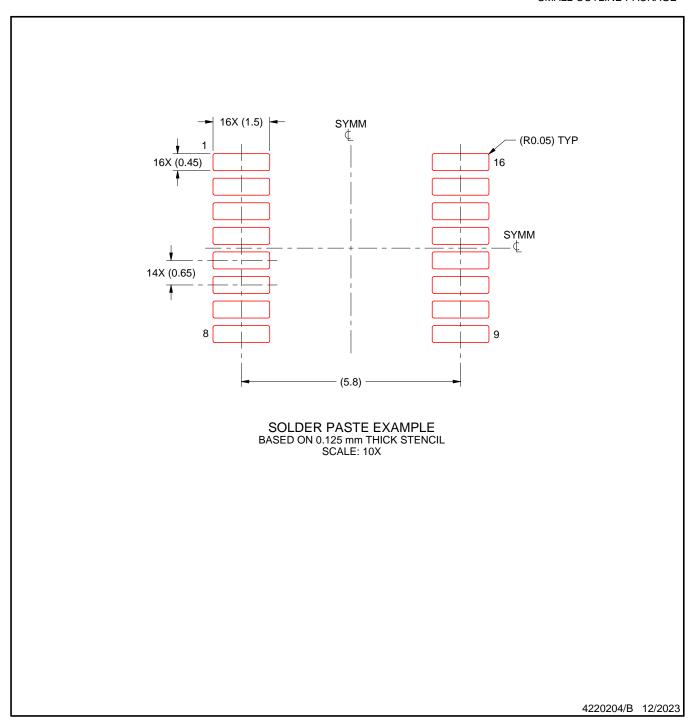
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOF



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOF



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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